

<b>Notice of References Cited</b>	Application/Control No. 10/532,298	Applicant(s)/Patent Under Reexamination TANAKA ET AL.
	Examiner Tung X. Le	Art Unit 2821

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0047805	04-2002	Yamamoto et al.	343/700.0MS
*	B	US-2002/0044099	04-2002	Yamamoto et al.	343/789
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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